

<b>Notice of References Cited</b>	Application/Control No. 09/883,300		Applicant(s)/Patent Under Reexamination BOYSKO ET AL.	
	Examiner THU HA T. NGUYEN		Art Unit 2453	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0083095 A1	06-2002	Wu et al.	707/513
*	B	US-6,438,550 B1	08-2002	Doyle et al.	1/1
*	C	US-2002/0123957 A1	09-2002	Notarius et al.	705/37
*	D	US-6,453,353 B1	09-2002	Win et al.	709/229
*	E	US-2002/0143655 A1	10-2002	Elston et al.	705/26
*	F	US-6,640,302 B1	10-2003	Subramaniam et al.	713/169
*	G	US-6,654,891 B1	11-2003	Borsato et al.	726/6
*	H	US-2003/0217333 A1	11-2003	Smith et al.	715/513
*	I	US-6,662,231 B1	12-2003	Drosset et al.	709/229
*	J	US-6,732,179 B1	05-2004	Brown et al.	709/229
*	K	US-6,763,468 B2	07-2004	Gupta et al.	726/2
*	L	US-7,356,840 B1	04-2008	Bedell et al.	726/13
*	M	US-7,698,398 B1	04-2010	Lai, Ray Y	709/223

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.